

Notice of References Cited	Application/Control No. 10/665,154	Applicant(s)/Patent Under Reexamination YOSHINO ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,522,861	02-2003	Tokutake et al.	399/401
	C	US-6,173,147	01-2001	Nakashima et al.	399/308
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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